Searcn Notes		

Application No.	Applicant(s)	
09/889,956	QUENZER ET AL.	
Examiner	Art Unit	
Carlos Lopez	1731	

SEARCHED			
Class	Subclass	Date	Examiner
65	37,41,44, 63,62, 93-95	5/4/2004	CL
65	102,104	5/4/2004	CL
65	107,273	5/4/2004	CL
264	316	5/4/2004	CL
264	299	5/4/2004	CL
264	300	5/4/2004	CL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
Inventorship search, Key word search: annealling, microlenses,micro lens, etching, anodic bonding.	5/1/2004	CL